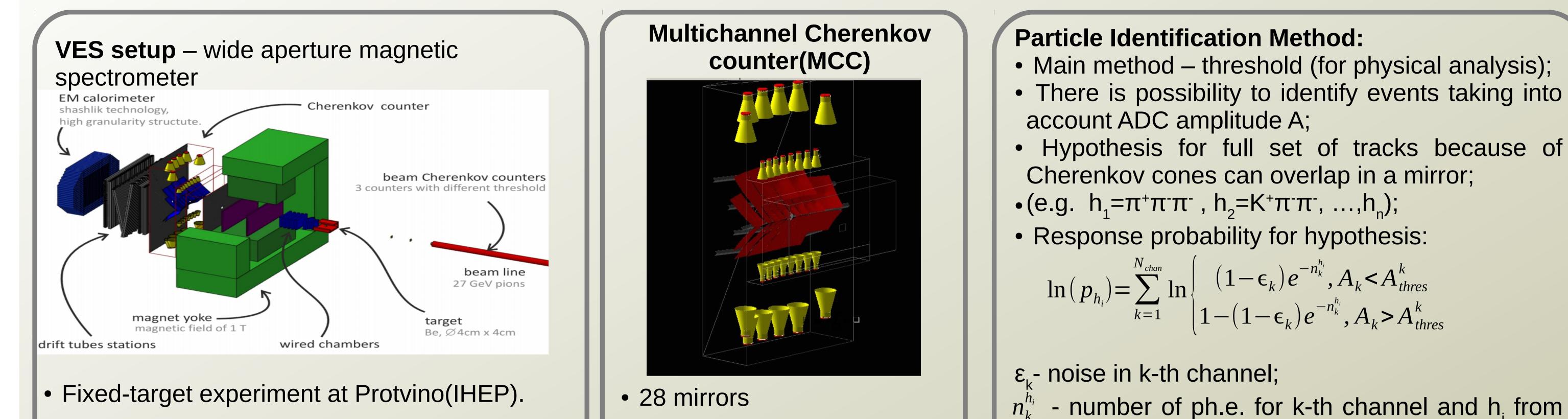
Particle identification with Cherenkov detector in VES experiment

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- Main goal: hadron spectroscopy. $\pi N_{target} \rightarrow m X k X^{\dagger} n \gamma N_{recoil}$
- Be target.
- π^{-} beam 29 GeV/c.

- (15x30cm²,30x55cm²).
- 28 light collecting cones.
- 1.6 m R-22 gas radiator.
- FEU-110, FEU-125.
- Measure ADC amplitude A

Cherenkov counter MODEL Fast simplified GEANT4 High speed More detailed geometry Possibility of tuning parameters Physical process in material

Photons reflect in cones Time dependency of refraction index

account for physical and Explicit account for reflection index Effective apparatus noises dispersion

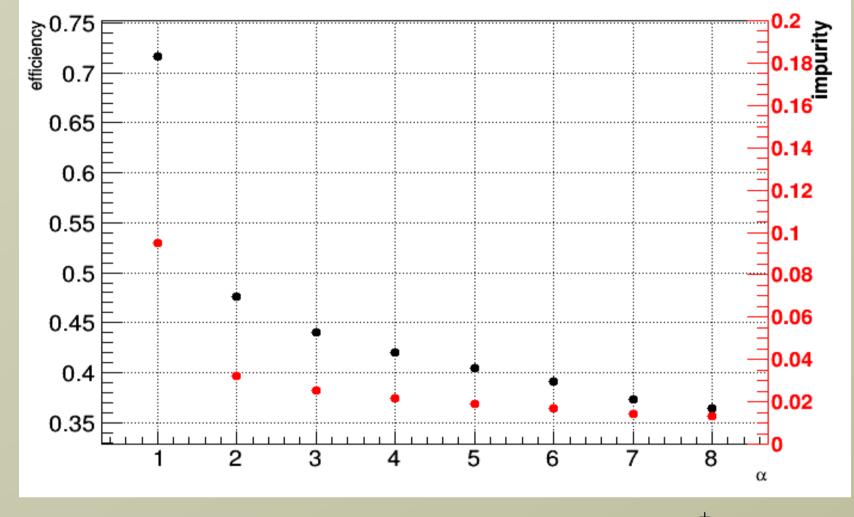
Response only for reconstructed tracks Response for all charged particles

track information and model.

• sort hypothesis $(h_1, \dots, h_n) \leftrightarrow (p_{\max}, p_{next}, \dots, p_{\min})$

 $\frac{P_{max}}{\alpha} > \alpha$ • Event is identified with hypothesis h₁, if:

• α – parameter of balance between efficiency and purity of identification.



Efficiency and impurity for $\pi N_{target} \rightarrow \pi \pi \pi \pi N_{recoil}$ MC events versus α

Model Parameters:

- Counter position;
- Mirrors position;
- Mirror angles;
- Noises of channels;
- Refraction index of gas n;
- Coefficients photons to photoelectrons k_{phe}.

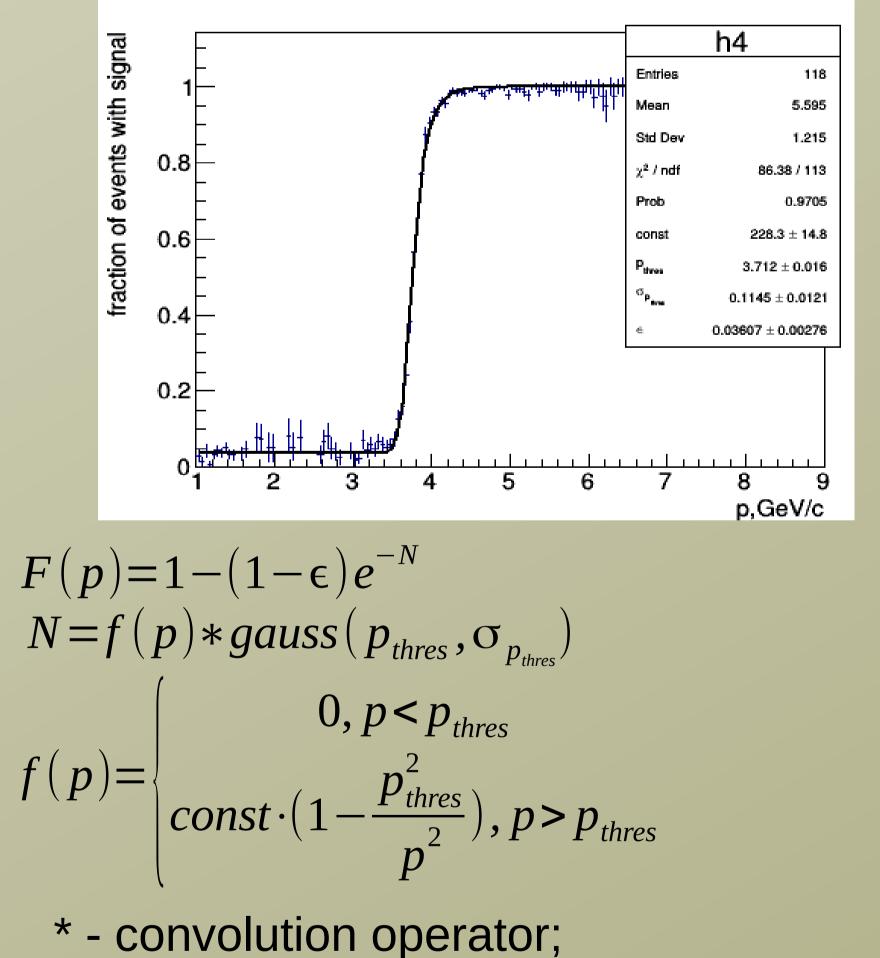
Model Parameters are obtained and verified using various experimental data samples.

Main reaction: $\pi N_{target} \rightarrow \pi 2 \pi^0 N_{recoil}$ (K⁻<0.5%).

Likelihood maximization to get mirror angles and k_{ph.e.}.

$$L = \sum_{i=1}^{N_{ev}} \sum_{k=1}^{28} \ln \left\{ \frac{(1 - \epsilon_k) e^{-n_{k_i}}, A_k < A_{thres_k}}{1 - (1 - \epsilon_k) e^{-n_{k_i}}, A_k > A_{thres_k}} \right\}$$

Fit curve to get threshold momentum of cherenkov radiation



 $gauss(p_{thres}, \sigma_{p_{thres}})$ – for effective account for refraction index dispersion.

Model applications:

- Calculate response for different event hypothesis and identify events;
- For modeling of events efficiency and misidentification;

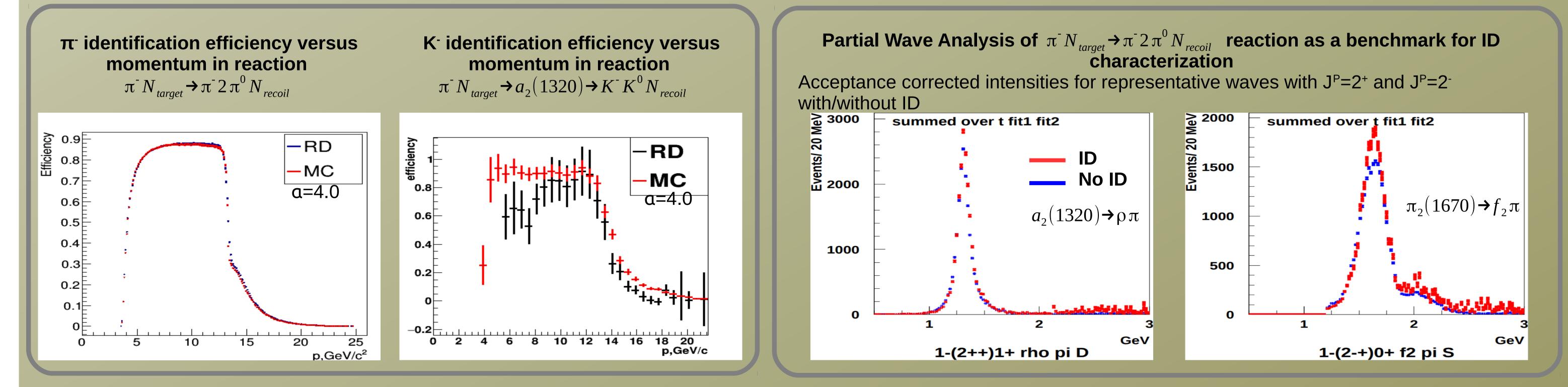
Model allows to generate ADC signals:

 $A = A_{sig} + A_{noise}$

A_{sig} – signal amplitude - random number from distribution:

$$S_k = \sum_{i=1}^{30} \frac{n_k^i e^{-n_k}}{n_k!} s_k^i$$

 n_{k} – number of ph.e. for k-th channel; s_k^{i} - i-times convolution of single electron spectrum for k-th channel.



* - supported by RFBR, project № 20-02-00246 A Poster presented at INSTR-2020 Conference, 24th-28th February 2020, Novosibirsk, Russia